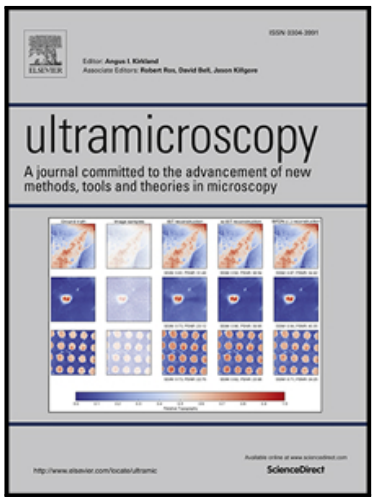

Twenty years after: how “Aberration Correction in the STEM” truly placed a “A Synchrotron in a Microscope

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Highlights

- Two seminal lectures delivered at the 1997 Electron Microscopy and Analysis Group conference are revisited in the context of two decades of STEM instrumentation development.
- The history of the SuperSTEM Laboratory and its close relationship with Ondrej Krivanek's work are highlighted.
- Recent results obtained with SuperSTEM 3, the latest generation of Nion monochromated microscope are briefly reviewed.